

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/572,652	OSCHMANN, H	EIKO
Examiner	Art Unit	
ANGELA J. MARTIN	1795	

	SEARCHED		
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Class	Subclass	Date	Examiner

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM inventor name search	12/4/2010	AJM		
EAST term &inventor name search (USPAT, USPGPUB, OCR, EPO, JPO, DERWENT)				
Reviewed IDS				
Reviewed 371	12/4/2010	AJM		